IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No.

10/544,190

Applicant

Takahiro Ike et al.

Filed

August 2, 2005

Title

IMAGING SYSTEM

Conf. No.

8297

TC/A.U.

2851

Examiner

TBD

Customer No.

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Docket No.

37547

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir/Madam:

In accordance with Rule 56, applicants are aware of the publications listed in the Supplementary European Search Report (copy enclosed) and in the enclosed copy of Patent Office Form 1449. In accordance with 37 CFR § 1.98, copies of the U.S. patents and U.S. patent application publications are not enclosed. A copy of each of the remaining publications is enclosed herewith.

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Mail Stop Amendment, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on the date indicated below.

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May 3, 2006

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The undersigned hereby certifies that each item of information contained in this Information Disclosure Statement was first cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this Information Disclosure Statement.

If there are any fees resulting from this communication, please charge said fees to Deposit Account No. 16-0820, Order No. 37547.

Respectfully submitted,

PEARNE & GORDON LLP

By:

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Date: May 3, 2006

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INFORMATION DISCLOSURE CITATION BY APPLICANT (USE SEVERAL SHEETS IF NECESSARY)					APPLICANT: Takahiro Ike et al.				
8 500g R	1906 y Page 1 of 1					FILING DATE: August 2, 2005		GROUP ART UNIT: 2851	
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Examiner Initial		Document No.	Date	Na	ime	Class	S	ubclass	Filing Date
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	C	THER REFEREN	CES (Includ	ling Author,	Title, Date	e, Pertinent	Pag	es, Etc.)	
	L	Patent Abstracts of Japan vol. 1997, no. 11, November 28, 1997 & JP 09-182059, July 11, 1997, abstract.							
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